

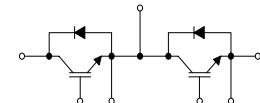
## “HALF-BRIDGE” IGBT

### Features

- IGBT NPT Technology
- 10µs Short Circuit Capability
- Low Turn-off losses
- Short tail current
- Positive V<sub>CE(on)</sub> temperature coefficient
- AC & DC Motor controls
- General purpose inverters
- Optimized for high current inverter (AC TIG Welding machines)
- Servo Controls
- UPS, Robotics

### Applications

**V<sub>CES</sub> = 1200V**  
**I<sub>c</sub> = 200A**  
**V<sub>CE(ON)</sub> typ. = 3.2V**  
**@ I<sub>c</sub> = 200A**



**Package : V3**

### Absolute Maximum Ratings @ T<sub>j</sub>=25°C (per leg)

Symbol	Parameter	Condition	Ratings	Unit
V <sub>CES</sub>	Collector-to-Emitter Voltage	V <sub>GE</sub> = 0V, I <sub>c</sub> = 1.0mA	1200	V
V <sub>GES</sub>	Gate emitter voltage		± 20	V
I <sub>c</sub>	Continuous Collector Current	T <sub>c</sub> = 70°C (25°C)	200 (260)	A
I <sub>CM</sub>	Pulsed collector current	T <sub>c</sub> = 70°C (25°C)	400 (520)	A
I <sub>F</sub>	Diode Continuous Forward Current	T <sub>c</sub> = 70°C (25°C)	200 (260)	A
I <sub>FM</sub>	Diode Maximum Forward Current		520	A
T <sub>sc</sub>	Short Circuit Withstand Time	T <sub>c</sub> = 100°C	10	µs
V <sub>iso</sub>	Isolation Voltage test	AC 1 minute	2500	V
T <sub>j</sub>	Junction Temperature		-40 ~ 150	°C
T <sub>stg</sub>	Storage Temperature		-40 ~ 125	°C
Weight	Weight of Module		360	g
Mounting	Power Terminal Screw : M5		3.5	Nm
Torque	Terminal connection Screw : M5		3.5	Nm

### Electrical Characteristics @ T<sub>j</sub> = 25°C (unless otherwise specified)

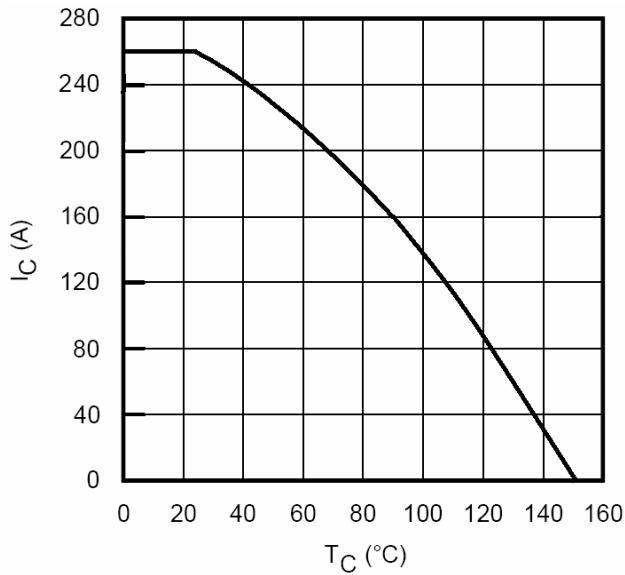
Symbol	Parameters	Min	Typ	Max	Unit	Test conditions
V <sub>(BR)CES</sub>	Collector-to-Emitter Breakdown Voltage	1200	-	-	V	V <sub>GE</sub> = 0V, I <sub>c</sub> = 1.0mA
V <sub>CE(ON)</sub>	Collector-to-Emitter Saturation Voltage	-	3.2	3.5		I <sub>c</sub> = 200A, V <sub>GE</sub> = 15V
V <sub>GE(th)</sub>	Gate Threshold Voltage	4.0	5.0	6.0		V <sub>CE</sub> = V <sub>GE</sub> , I <sub>c</sub> = 500µA
I <sub>CES</sub>	Zero Gate Voltage Collector Current	-	-	1.0	mA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 1200V
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	-	-	±200	nA	V <sub>CE</sub> = 0V, V <sub>GE</sub> = ±20V
V <sub>FM</sub>	Diode Forward Voltage Drop	-	2.4	2.7	V	I <sub>c</sub> = 200A

**Switching Characteristic @ T<sub>j</sub> = 25 °C (unless otherwise specified)**

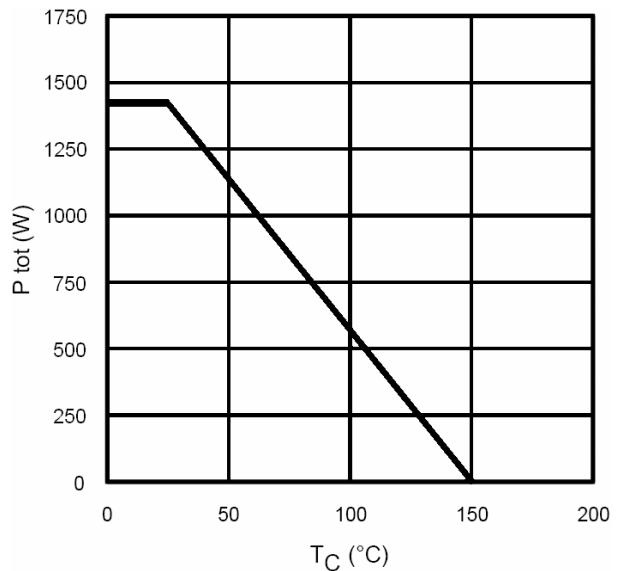
Symbol	Parameters	Min	Typ	Max	Unit	Test conditions
C <sub>ies</sub>	Input capacitance	-	8600	-	pF	V <sub>CC</sub> = 30V, V <sub>GE</sub> = 0V f = 1.0MHz
C <sub>oss</sub>	Output capacitance	-	790	-		
C <sub>res</sub>	Reverse transfer capacitance	-	320	-		
t <sub>d(on)</sub>	Turn-on delay time	-	72	94	ns	T <sub>j</sub> = 125 °C, V <sub>CC</sub> = 600V I <sub>C</sub> = 200A, V <sub>GE</sub> = 15V R <sub>G</sub> = 4.7Ω
t <sub>r</sub>	Rise time	-	32	45		
t <sub>d(off)</sub>	Turn-off delay time	-	366	400		
t <sub>f</sub>	Fall time	-	45	58		
I <sub>rr</sub>	Diode Peak Reverse Recovery current	-	50	-	A	T <sub>j</sub> = 125 °C, V <sub>CC</sub> = 600V I <sub>F</sub> = 120A, V <sub>GE</sub> = 15V R <sub>G</sub> = 4.7Ω
t <sub>rr</sub>	Diode Reverse Recovery time	-	180	-	ns	

**Thermal Characteristic Values**

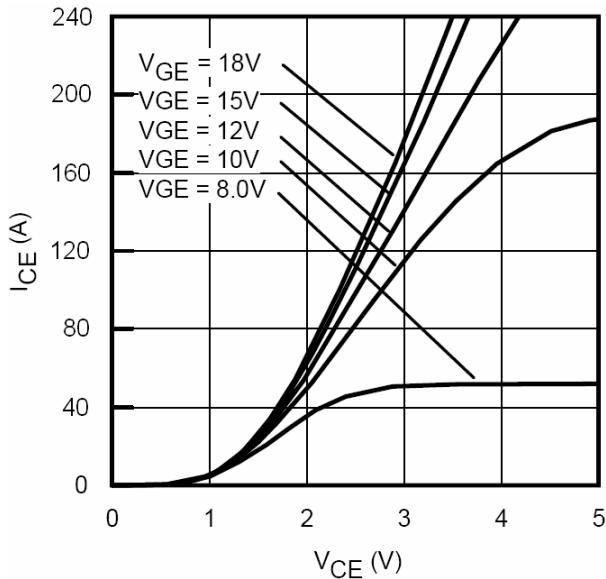
Symbol	Parameters	Min	Typ	Max	Unit
R <sub>θJC</sub>	Junction-to-Case (IGBT Part, Per 1/2 Module)	-	-	0.10	W/°C
R <sub>θJC</sub>	Junction-to-Case (Diode Part, Per 1/2 Module)	-	-	0.20	
R <sub>θCS</sub>	Case-to-Heat Sink (Conductive grease applied)	-	0.04	-	



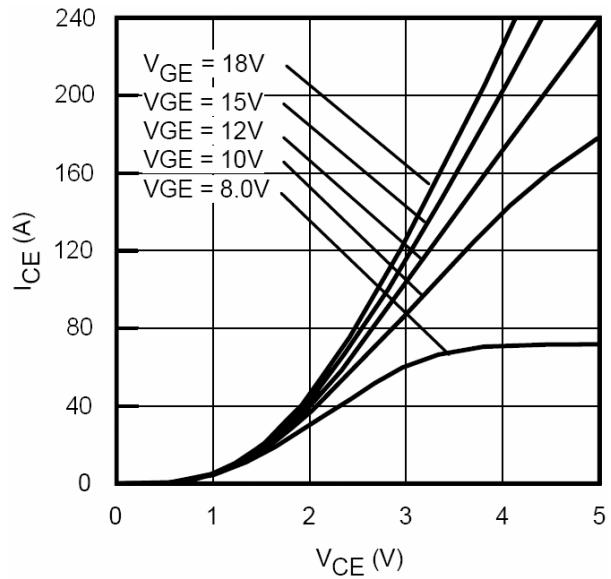
**Fig 1. Maximum DC Collector Current  
vs. Case Temperature**



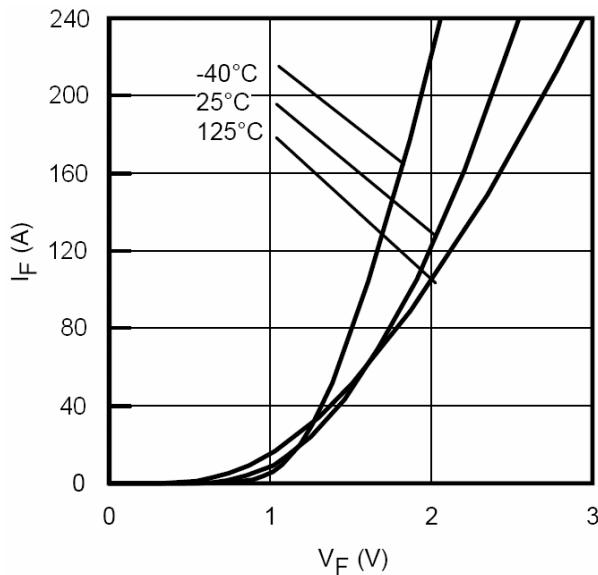
**Fig 2. Power Dissipation vs. Case  
Temperature**



**Fig 3. Typ. IGBT Output Characteristics  
 $T_j = 25^\circ\text{C}; t_p = 80\mu\text{s}$**

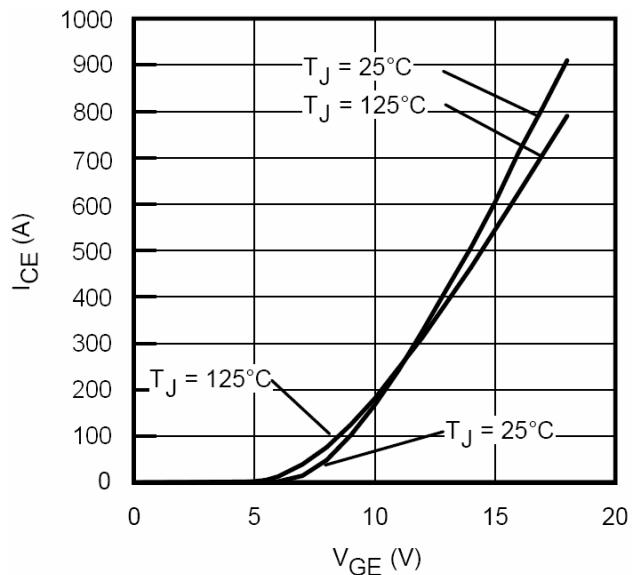


**Fig 4. Typ. IGBT Output Characteristics  
 $T_j = 125^\circ\text{C}; t_p = 80\mu\text{s}$**



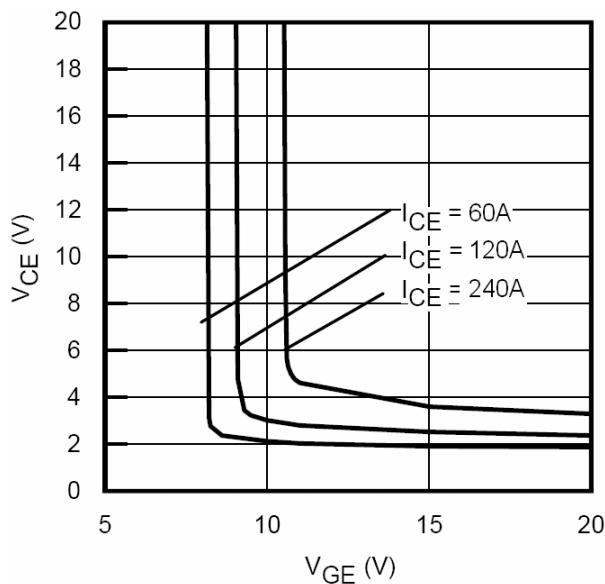
**Fig 5. Typ. Diode Forward Characteristics**

$t_p = 80\mu\text{s}$



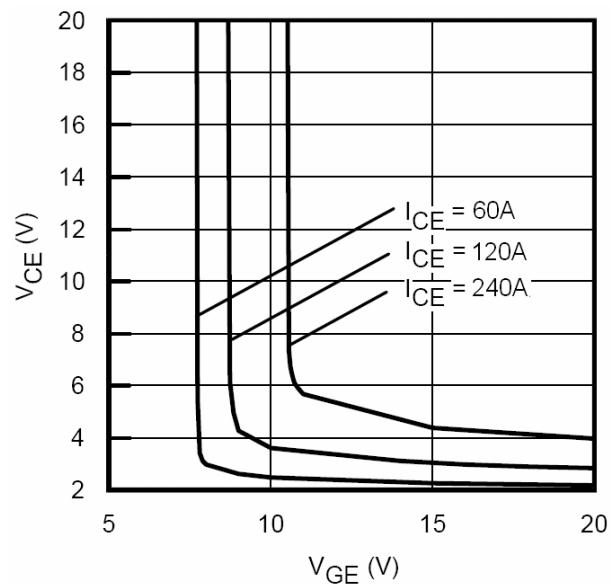
**Fig 6. Typ. Transfer Characteristics**

$V_{CE} = 50\text{V}$ ;  $t_p = 10\mu\text{s}$



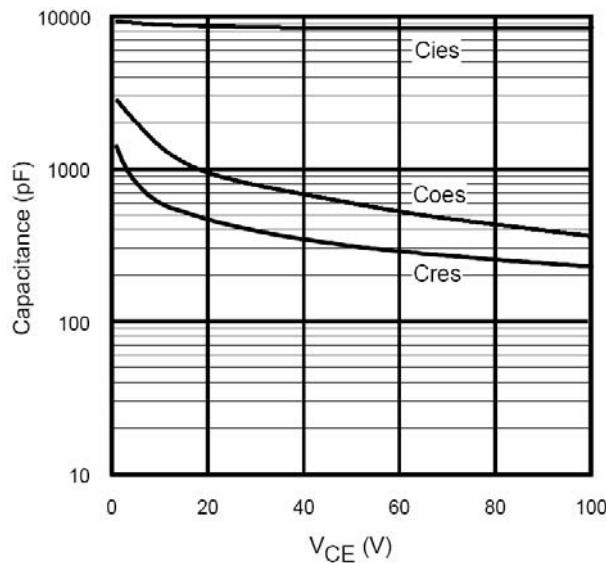
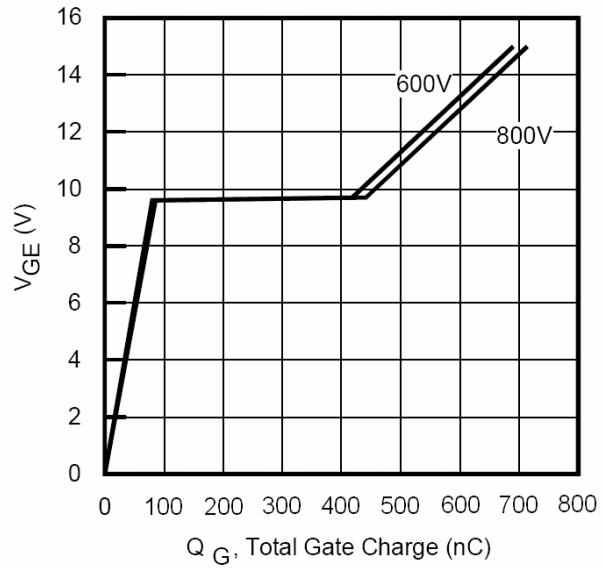
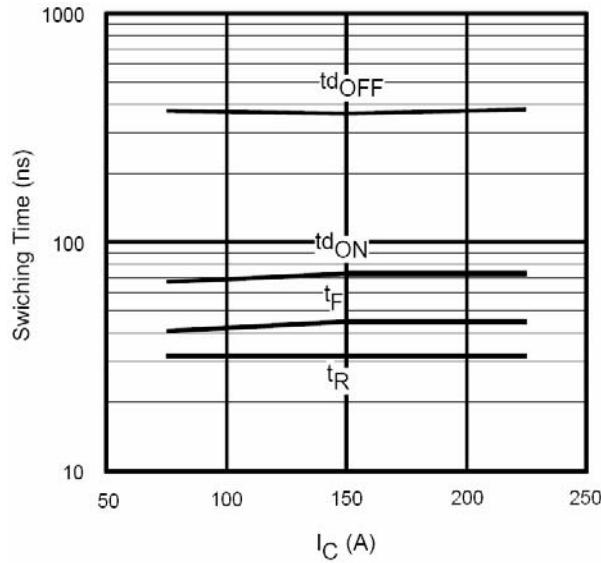
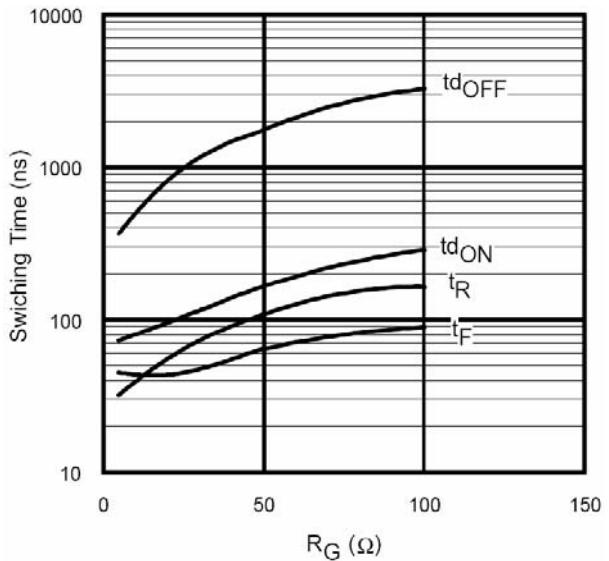
**Fig 7. Typical  $V_{CE}$  vs.  $V_{GE}$**

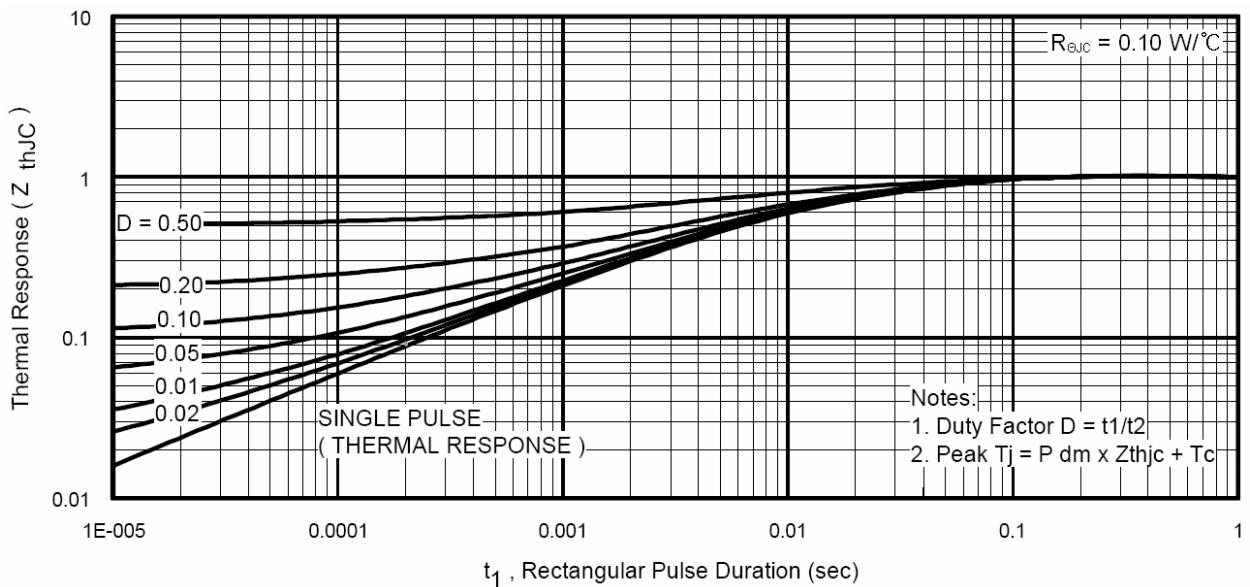
$T_J = 25^\circ\text{C}$



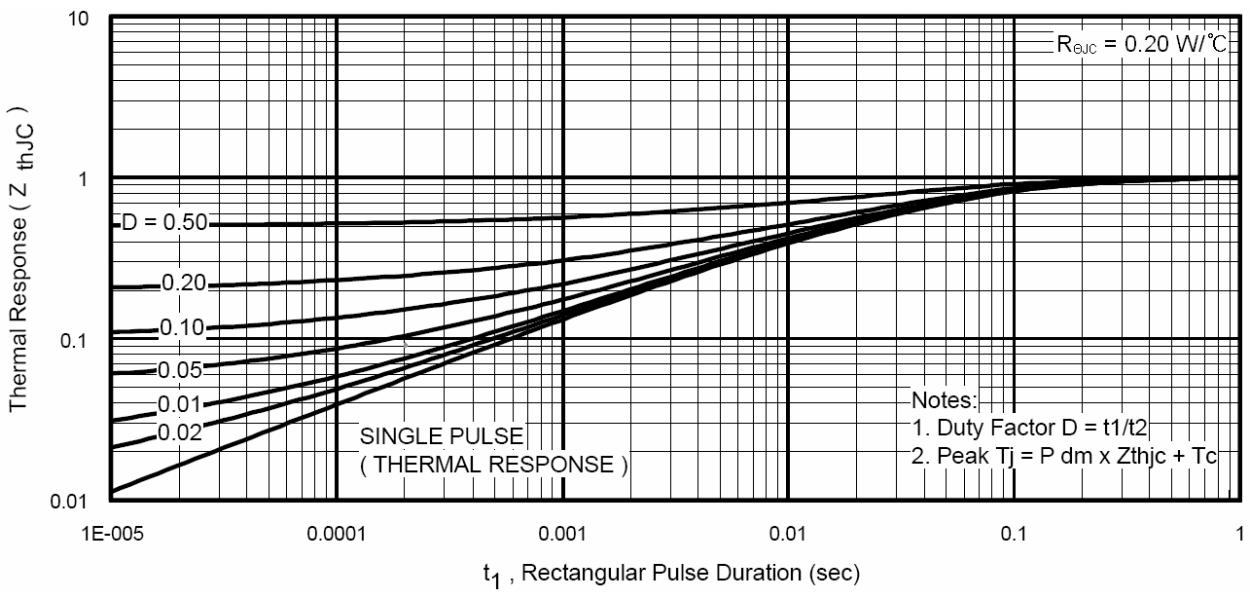
**Fig 8. Typical  $V_{CE}$  vs.  $V_{GE}$**

$T_J = 125^\circ\text{C}$

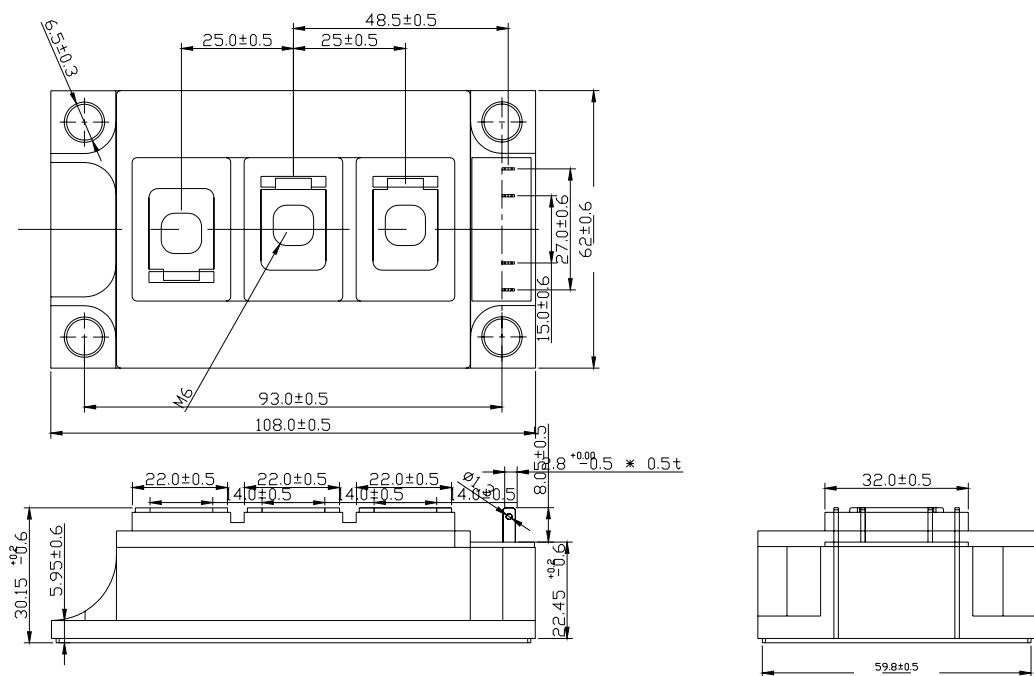

**Fig 9. Typ. Capacitance vs.  $V_{CE}$** 
 $V_{GE} = 0V; f = 1Mhz$ 

**Fig 10. Typical Gate Charge vs.  $V_{GE}$** 
 $I_{CE} = 120A; L = 600\mu H$ 

**Fig 11. Typ. Switching Time vs.  $I_C$** 
 $T_J = 125^\circ C; L = 200\mu H; V_{CE} = 600V$ 
 $R_G = 4.7\Omega; V_{GE} = 15V$ 

**Fig 12. Typ. Switching Time vs.  $R_G$** 
 $T_J = 125^\circ C; L = 200\mu H; V_{CE} = 600V$ 
 $I_{CE} = 200A; V_{GE} = 15V$



**Fig 13. Normalized Transient Thermal Impedance, Junction-to-Case (IGBT)**



**Fig 14. Normalized Transient Thermal Impedance, Junction-to-Case (DIODE)**

**Package Outline** (dimensions in mm)


Data and specifications subject to change without notice.

May 2006